

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	$T_j$ (°C)	VALUE			UNIT
				Min	Type	Max	
$I_{T(AV)}$	Mean on-state current	180° half sine wave 50Hz Double side cooled, $T_{hs}=55^\circ C$	115			665	A
$I_{T(AV)}$	Mean on-state current	180° half sine wave 50Hz Double side cooled, $T_{hs}=80^\circ C$	115			450	A
$V_{DRM}$ $V_{RRM}$	Repetitive peak off-state voltage Repetitive peak reverse voltage	$V_{DRM} \& V_{RRM}$ tp=10ms $V_{DsM} \& V_{RsM} = V_{DRM} \& V_{RRM} + 100V$ respectively	115	800		1200	V
$I_{DRM}$ $I_{RRM}$	Repetitive peak current	at $V_{DRM}$ at $V_{RRM}$	115			40	mA
$I_{TSM}$	Surge on-state current	10ms half sine wave	115			4.8	KA
$I^2T$	$I^2T$ for fusing coordination	$V_R=0.6V_{RRM}$				115	$A^2s*10^3$
$V_{TO}$	Threshold voltage		115			1.48	V
$r_T$	On-state slop resistance					0.67	$m\Omega$
$V_{TM}$	Peak on-state voltage	$I_{TM}=1200A$ , $F=15KN$	115			2.28	V
$dv/dt$	Critical rate of rise of off-state voltage	$V_{DM}=0.67V_{DRM}$	115			200	$V/\mu s$
$di/dt$	Critical rate of rise of on-state current	From 67% $V_{DRM}$ to 1500A, Gate source 1.5A $t_r \leq 0.5\mu s$ Repetitive	115			200	$A/\mu s$
$I_{rm}$	Reverse recovery current	$I_{TM}=800A$ , tp=1000 $\mu s$ , $di/dt=-40A/\mu s$ , $V_R=50V$	115			30	A
$t_{rr}$	Reverse recovery time					2.2	$\mu s$
$Q_{rr}$	Recovery charge					33	$\mu C$
$t_q$	Circuit commutated turn-off time	$I_{TM}=800A$ , tp=1000 $\mu s$ , $V_R = 50V$ $dv/dt=30V/\mu s$ , $di/dt=-40A/\mu s$	115	6		10	$\mu s$
$I_{GT}$	Gate trigger current	$V_A=12V$ , $I_A=1A$	25			30	mA
$V_{GT}$	Gate trigger voltage			0.8		3.0	V
$I_H$	Holding current			20		400	mA
$V_{GD}$	Non-trigger gate voltage	At 67% $V_{DRM}$	115			0.3	V
$R_{th(j-h)}$	Thermal resistance Junction to heatsink	At 180° sine double side cooled Clamping force 15KN				0.035	$^\circ C / W$
$F_m$	Mounting force					10	KN
$T_{stg}$	Stored temperature					-40	140
$W_t$	Weight					270	g
Outline	KT33cT						

## Outline

